

Search Notes**Application/Control No.**

10/667,776

Examiner

Young J. Kim

Applicant(s)/Patent under Reexamination

SU ET AL.

Art Unit

1637

SEARCHED

Class	Subclass	Date	Examiner
422	80	5/16/2005	
	82.01	5/16/2005	
	82.02	5/16/2005	
	82.05	5/16/2005	
435	6	5/16/2005	

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Patent Databases (USPT, USPPG, EPO, JPO, DERWENT, IBM-TDB)	5/16/2005	YJK
See enclosed for search strategy	5/16/2005	YJK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner